

SEMITOP®E1 Solder

3-phase Converter-Inverter-Brake (CIB)

Engineering Sample SK25DGDL12T7ETE1s

Target Data

Features*

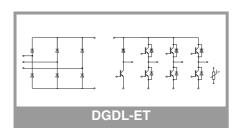
- Optimized design for superior thermal performance
- · Low inductive design
- Solder contact technology
- 1200V Generation 7 IGBT (T7)
- Robust and soft switching CAL4F diode technology
- PEP rectifier diode technology for enhanced power and environmental robustness
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks

Absolute	Maximum Rating	s		
Symbol	Conditions		Values	Unit
Inverter -	İGBT			
V _{CES}	T _j = 25 °C		1200	V
Ic	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	41	Α
	T _j = 175 °C	T _s = 70 °C	33	Α
I _C	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	47	Α
	T _j = 175 °C	T _s = 70 °C	38	Α
I _{Cnom}		1	25	Α
I _{CRM}			50	Α
V _{GES}			-20 20	V
t _{psc}	$V_{CC} = 800 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1200 \text{ V}$	T _j = 175 °C	7	μѕ
Tj		<u>.</u>	-40 175	°C
Chopper	- IGBT		•	
V _{CES}	T _j = 25 °C		1200	V
Ic	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	41	Α
	T _j = 175 °C	T _s = 70 °C	33	Α
Ic	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	47	Α
	T _j = 175 °C	T _s = 70 °C	38	Α
I _{Cnom}			25	Α
I _{CRM}			50	А
V _{GES}			-20 20	V
t _{psc}	$V_{CC} = 800 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1200 \text{ V}$	T _j = 175 °C	7	μs
Tj		<u> </u>	-40 175	°C
Inverse -	Diode			
V _{RRM}	T _j = 25 °C		1200	V
I _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	21	Α
	T _j = 175 °C	T _s = 70 °C	17	Α
l _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	24	Α
	T _j = 175 °C	T _s = 70 °C	20	Α
I _{FRM}		1	45	Α
I _{FSM}	$t_p = 10 \text{ ms, sin } 180^\circ$	°, T _i = 150 °C	65	Α
Tj	·		-40 175	°C
	eling - Diode		-	
V _{RRM}	T _i = 25 °C		1200	V
l _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	15	Α
	T _j = 175 °C	T _s = 70 °C	12	Α
l _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	16	А
	T _j = 175 °C	T _s = 70 °C	13	Α
I _{FRM}	1	I	20	Α
I _{FSM}	$t_p = 10 \text{ ms, sin } 180^\circ$	°, T _i = 150 °C	36	Α
. 0141	_, _	· 1	1	1





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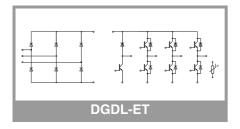
Typical Applications

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Remarks

Absolute Maximum Ratings						
Symbol	Conditions		Values	Unit		
Rectifier -	- Diode					
V_{RRM}	T _j = 25 °C		1600	V		
I _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	61	Α		
	T _j = 175 °C	T _s = 70 °C	47	Α		
I _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	72	Α		
	T _j = 175 °C	T _s = 70 °C	57	Α		
I _{FSM}	t _p = 10 ms sin 180°	T _j = 25 °C	370	Α		
		T _j = 150 °C	270	Α		
i ² t	t _p = 10 ms	T _j = 25 °C	685	A ² s		
	sin 180°	T _j = 150 °C	365	A ² s		
Tj			-40 175	°C		
Module				•		
I _{t(RMS)}	, ΔT _{terminal} at PCB joint = 30 K, per pin		30	Α		
T _{stg}	module without TIM		-40 125	°C		
V _{isol}	AC, sinusoidal, 1 min		2500	V		

Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -	IGBT		•			
V _{CE(sat)}	I _C = 25 A	T _j = 25 °C		1.60	1.75	V
	$V_{GE} = 15 \text{ V}$	T _j = 150 °C		1.82	1.96	V
	chiplevel	T _j = 175 °C		1.86	2.00	V
V_{CE0}		T _j = 25 °C		0.90	1.00	V
	chiplevel	T _j = 150 °C		0.75	0.83	V
		T _j = 175 °C		0.72	0.80	V
r _{CE}	V 45.V	T _j = 25 °C		28	30	mΩ
	V _{GE} = 15 V chiplevel	T _j = 150 °C		43	45	mΩ
		T _j = 175 °C		46	48	mΩ
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_{C} = 0.5$	3 mA	5.15	5.8	6.45	V
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 12$	200 V, T _j = 25 °C			1	mA
C _{ies}	V 05.V	f = 1 MHz		4.8		nF
Coes	$V_{CE} = 25 \text{ V}$ $V_{GF} = 0 \text{ V}$	f = 1 MHz		0.0615		nF
C _{res}	VGE - V	f = 1 MHz		0.017		nF
Q_G	V _{GE} = -15V+15V			354		nC
R _{Gint}	T _j = 25 °C			0		Ω
t _{d(on)}	$V_{CC} = 600 \text{ V}$ $I_{C} = 25 \text{ A}$ $R_{G \text{ on}} = 6.2 \Omega$ $R_{G \text{ off}} = 6.2 \Omega$ $V_{GE} = +15/-15 \text{ V}$	T _j = 25 °C		28		ns
		T _j = 150 °C		30		ns
		T _j = 175 °C		32		ns
t _r		T _j = 25 °C		23		ns
		T _j = 150 °C		25		ns
	(T _i = 150 °C)	T _j = 175 °C		26		ns
E _{on}	$di/dt_{on} = 880 \text{ A/}\mu\text{s}$ $di/dt_{off} = 210 \text{ A/}\mu\text{s}$	T _j = 25 °C		1.41		mJ
		T _j = 150 °C		2.06		mJ
	dv/dt = 5400 V/μs	T _j = 175 °C		2.32		mJ





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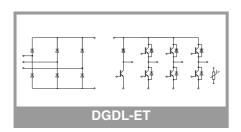
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- · Low inductive design
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- 1200V Generation 7 IGBT (T7)
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- PEP rectifier diode technology for enhanced power and environmental robustness
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks



Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -				,.		
t _{d(off)}		T _i = 25 °C		191		ns
4(0)	$V_{CC} = 600 \text{ V}$ $I_{C} = 25 \text{ A}$	T _i = 150 °C		231		ns
	$R_{G \text{ on}} = 6.2 \Omega$	T _i = 175 °C		251		ns
t _f	$R_{G \text{ off}} = 6.2 \Omega$	T _i = 25 °C	66			ns
•	$V_{GE} = +15/-15 \text{ V}$	T _i = 150 °C		101		ns
	(T _i = 150 °C)	T _i = 175 °C		108		ns
E _{off}	$di/dt_{on} = 880 \text{ A/}\mu\text{s}$	T _i = 25 °C		2.04		mJ
	di/dt _{off} = 210 A/μs	T _i = 150 °C		2.71		mJ
	dv/dt = 5400 V/μs	T _i = 175 °C		3.09		mJ
R _{th(j-s)}	per IGBT, λ _{paste} =0.	l '		1.32		K/W
R _{th(j-s)}	per IGBT, λ_{paste} =2.			1.06		K/W
Chopper						1
V _{CE(sat)}	I _C = 25 A	T _j = 25 °C		1.60	1.75	V
OL(Sai)	$V_{GE} = 25 \text{ A}$	T _i = 150 °C	†	1.82	1.96	V
	chiplevel	T _i = 175 °C		1.86	2.00	V
V _{CE0}		T _i = 25 °C		0.90	1.00	V
- 020	chiplevel	T _i = 150 °C		0.75	0.83	V
		T _i = 175 °C		0.72	0.80	V
r _{CE}		T _i = 25 °C		28	30	mΩ
.05	V _{GE} = 15 V	T _i = 150 °C		43	45	mΩ
	chiplevel	T _i = 175 °C		46	48	mΩ
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_{C} = 0.5$	ļ ·	5.15	5.8	6.45	V
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 12$		0.10	0.0	1	mA
Cies	VGE - O V, VCE - 12	f = 1 MHz	1	4.8		nF
C _{oes}	V _{CE} = 25 V	f = 1 MHz	1	0.0615		nF
C _{res}	$V_{GE} = 0 V$	f = 1 MHz		0.017		nF
Q _G	V _{GE} = -15V+15V	<u> </u>		354		nC
R _{Gint}	T _j = 25 °C		1	0		Ω
	1,1-20-0	T _j = 25 °C	1	28		ns
t _{d(on)}	-	T _i = 150 °C	1	30		ns
	-	T _j = 175 °C	1	32		ns
t _r	-	$T_j = 25 ^{\circ}\text{C}$	1	23		ns
-1	-	$T_j = 150 ^{\circ}\text{C}$		25		ns
	V _{CC} = 600 V	T _i = 175 °C		26		ns
E _{on}	I _C = 25 A	T _i = 25 °C		1.41		mJ
-011	$R_{G \text{ on}} = 6.2 \Omega$	T _i = 150 °C		2.06		mJ
	$R_{G \text{ off}} = 6.2 \Omega$ $V_{GE} = +15/-15 \text{ V}$	T _i = 175 °C	†	2.32		mJ
t _{d(off)}		T _j = 25 °C		191		ns
a(on)	(T _j = 150 °C)	T _i = 150 °C	1	231		ns
	$di/dt_{on} = 880 \text{ A/µs}$	T _i = 175 °C	†	251		ns
t _f	$di/dt_{off} = 210 \text{ A/}\mu\text{s}$ $dv/dt = 5400 \text{ V/}\mu\text{s}$	T _i = 25 °C	†	66		ns
•	αν/αι = 5400 ν/μδ	T _i = 150 °C	1	101		ns
	-	T _j = 175 °C	†	108		ns
E _{off}	-	T _j = 25 °C		2.04		mJ
-UII	-	T _i = 150 °C	†	2.71		mJ
	-	T _j = 175 °C		3.09		mJ
R _{th(j-s)}	per IGBT, λ _{paste} =0.	<u> </u>		1.32		K/W
-u i(J-5)		5 W/(mK)	-	1.06		K/W



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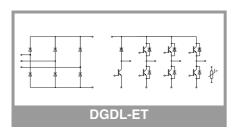
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Remarks

Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverse -	Diode			•		
$V_F = V_{EC}$	I _F = 15 A	T _i = 25 °C		2.38	2.71	V
1 10		T _i = 150 °C		2.44	2.77	V
	chiplevel	T _j = 175 °C		2.26	2.58	V
V _{F0}		T _j = 25 °C		1.30	1.50	V
10	chiplevel	T _i = 150 °C		0.90	1.10	V
	-	T _i = 175 °C		0.82	0.98	V
r _F		T _i = 25 °C		72	81	mΩ
· · · · · · · · · · · · · · · · · · ·	chiplevel	T _i = 150 °C	!	103	111	mΩ
		T _i = 175 °C		96	107	mΩ
I _{RRM}		T _i = 25 °C		16		Α
		T _i = 150 °C		23		Α
	V 600 V	T _i = 175 °C		24		Α
Q _{rr}	$V_{CC} = 600 \text{ V}$ $I_{F} = 25 \text{ A}$	T _i = 25 °C		1.01		μC
	$V_{GE} = -15 \text{ V}$	T _i = 150 °C		2.69		μC
	(T _j = 150 °C)	T _i = 175 °C		3.04		μC
E _{rr}	$di/dt_{off} = 1050 \text{ A/}\mu\text{s}$	T _i = 25 °C		0.37		mJ
		T _i = 150 °C		1.17		mJ
		T _i = 175 °C		1.79		mJ
R _{th(j-s)}	per Diode, λ _{paste} =0.	ļ ·		2.13		K/W
R _{th(j-s)}	per Diode, $\lambda_{paste}=2$.			1.74		K/W
	eling - Diode		I			1
$V_F = V_{EC}$	I _F = 10 A	T _j = 25 °C		2.59	2.94	V
		T _i = 150 °C		2.71	3.08	V
	chiplevel	T _j = 175 °C		2.53	2.89	V
V _{F0}		T _j = 25 °C		1.30	1.50	V
	chiplevel	T _j = 150 °C		0.90	1.10	V
		T _j = 175 °C		0.82	0.98	V
r _F		T _j = 25 °C		129	144	mΩ
	chiplevel	T _j = 150 °C		181	198	mΩ
	=	T _j = 175 °C		171	191	mΩ
I _{RRM}		T _j = 25 °C		8		Α
		T _j = 150 °C		14		Α
	V _{CC} = 600 V	T _i = 175 °C		16		Α
Q _{rr}	I _F = 10 A	T _j = 25 °C		0.58		μC
**	$V_{GE} = -15 \text{ V}$	T _i = 150 °C		2.01		μC
	(T _j = 150 °C)	T _j = 175 °C		2.37		μC
E _{rr}	di/dt _{off} = 790 A/μs	T _j = 25 °C		0.36		mJ
		T _j = 150 °C		0.91		mJ
		T _j = 175 °C		1.16		mJ
R _{th(j-s)}	per Diode, λ _{paste} =0.	1 -		2.64		K/W
R _{th(j-s)}	per Diode, λ _{paste} =2.			2.24		K/W





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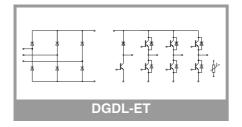
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Remarks

Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
Rectifier -	Diode					
V_{F}	1 OF A	T _j = 25 °C		1.04	1.30	V
	I _F = 25 A chiplevel	T _j = 150 °C		0.95	1.21	V
		T _j = 175 °C		0.94	1.21	V
V_{F0}		T _j = 25 °C		0.89	1.09	V
	chiplevel	T _j = 150 °C		0.73	0.92	V
		T _j = 175 °C		0.69	0.88	V
r _F	chiplevel	T _j = 25 °C		6.2	8.5	mΩ
		T _j = 150 °C		8.8	12	mΩ
		T _j = 175 °C		10.0	13	mΩ
I _R	$T_j = 150 ^{\circ}\text{C}, V_R$	RM			2	mA
R _{th(j-s)}	per Diode, λ_{pas}	_{te} =0.8 W/(mK)		1.48		K/W
R _{th(j-s)}	per Diode, λ _{paste} =2.5 W/(mK)			1.14		K/W
Module						
Ms	to heatsink		1.6		2.3	Nm
w				25		g
L _{CE}				30		nH
Temperat	ure Sensor					_
R ₁₀₀	T _c =100°C (R ₂₅	=5 kΩ)		493 ± 5%		Ω
B _{25/85}	$R_{(T)} = R_{25} * exp[E$	B _{25/85} *(1/T-1/298)], T[K]		3420		K



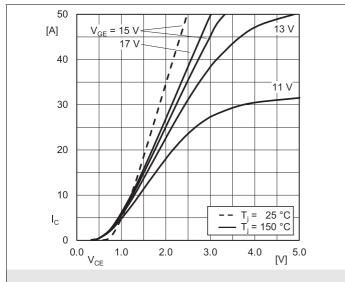


Fig. 1: Typ. IGBT output characteristic, incl. R_{CC+ EE}

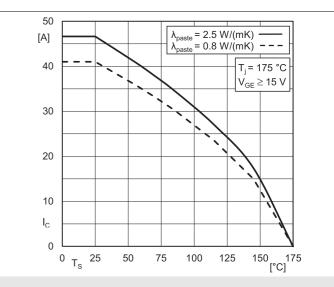


Fig. 2: IGBT rated current vs. temperature I_c=f(T_s)

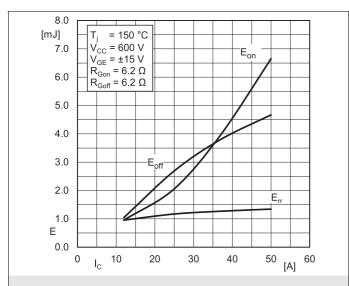


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

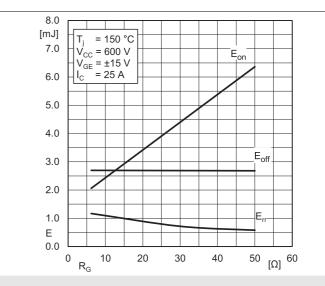


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

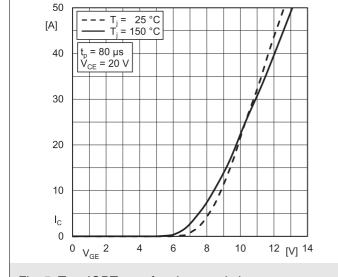


Fig. 5: Typ. IGBT transfer characteristic

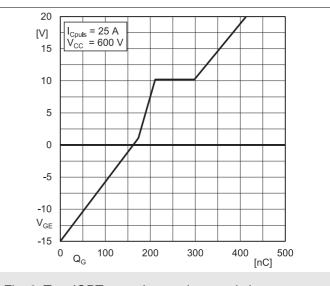
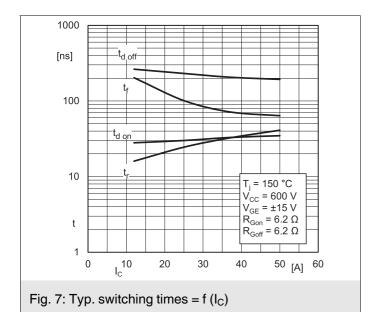
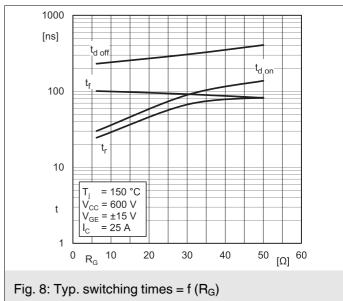
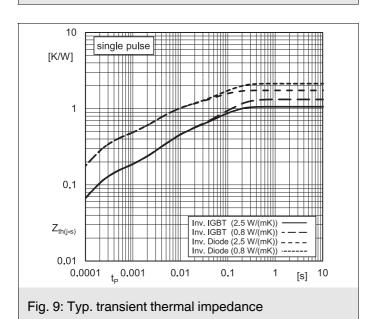
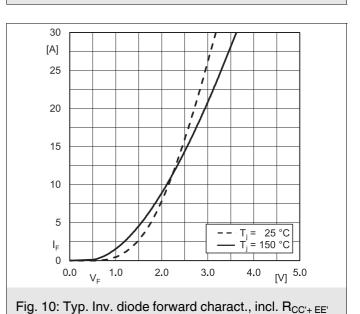


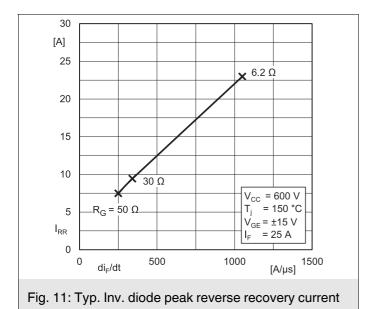
Fig. 6: Typ. IGBT gate charge characteristic











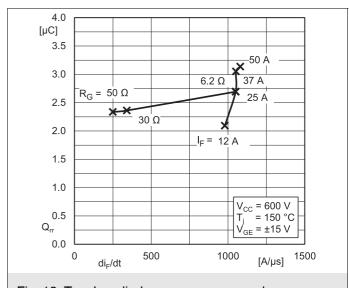


Fig. 12: Typ. Inv. diode reverse recovery charge

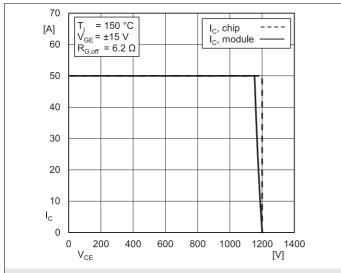


Fig. 13: IGBT Reverse Bias Safe Operating Area (RBSOA)

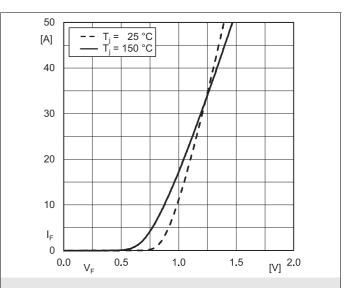
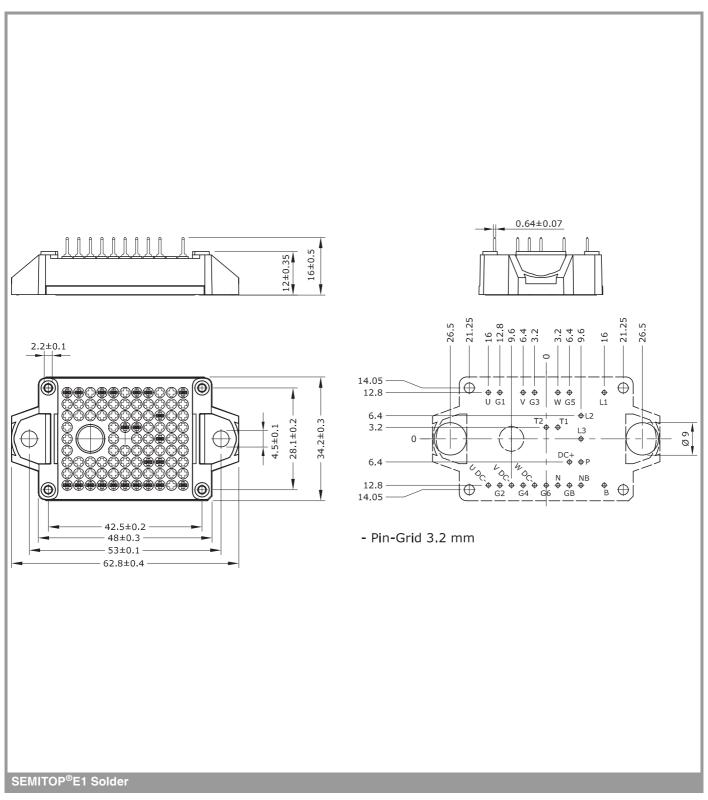
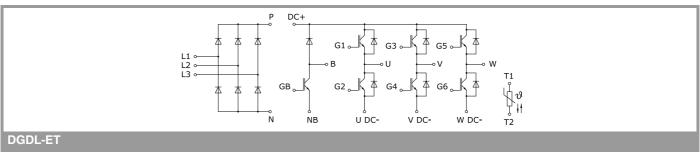


Fig. 14: Typ. Rect. diode forward charact., incl. $R_{\text{CC'+} \text{EE'}}$





This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

*IMPORTANT INFORMATION AND WARNINGS

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